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## Validation and comparison of FPGA-based real-time Thomson Scattering data processing against offline analysis methods

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A real-time signal processing unit based on FPGA has been developed for electron temperature (Te) evaluation in a Thomson scattering (TS) diagnostic system. The FPGA module is independent of the polychromator and is integrated with ADC and DAC components as a compact real-time processing unit. It receives five analog input channels directly from the spectral outputs of the polychromator and digitizes scattered signal pulses (~40 ns width) using a 16-bit, 1 GS/s ADC.

After background subtraction, each channel's waveform is integrated, consuming  $1.01~\mu s$  in simulation. The resulting integrals are then standardized across the five channels, a process taking  $4.26~\mu s$ . These standardized values are matched against a precomputed  $5001\times5$  spectral response database using a minimum-variance search algorithm. The database lookup takes  $12.4605~\mu s$  in simulation, yielding the Te estimate. A 16-bit DAC converts the result to a 0-10~V analog voltage, linearly corresponding to 1-5000~eV. Preliminary validation has been performed for Te; the electron density (ne) algorithm is under development. The system demonstrates sub-15  $\mu s$  processing latency and provides a viable foundation for future real-time plasma diagnostics and control applications.

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